

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination KASHIWA ET AL.	
		Examiner	Art Unit	Page 1 of 1

Rip A. Lee  
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,278,272 A	01-1994	Lai et al.	526/348.5
	B	US-6,300,433 B1	10-2001	Rodriguez et al.	526/127
	C	US-6,333,387 B1	12-2001	Takahashi et al.	525/240
	D	US-5,874,513 A	02-1999	Watanabe et al.	526/348.1
	E	US-5,783,638 A	07-1998	Lai et al.	525/240
	F	US-5,674,945 A	10-1997	Takahashi et al.	525/240
	G	US-5,519,091 A	05-1996	Tsutsui et al.	525/240
	H	US-5,218,071 A	06-1993	Tsutsui et al.	526/348
	I	US-2002/0107343 A1	08-2002	Kashiwa et al.	526/134
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 1 231 229 A2	08-2002	Europe	Kashiwa et al.	C08F 210/16
	O	EP 0 955 321 A2	11-1999	Europe	Tsutsui et al.	C08F 210/16
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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